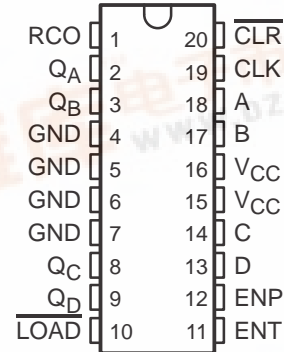


- Internal Look-Ahead for Fast Counting
- Carry Output for n-Bit Cascading
- Fully Synchronous Operation for Counting
- Flow-Through Architecture to Optimize PCB Layout
- Center-Pin V_{CC} and GND Pin Configurations Minimize High-Speed Switching Noise
- EPIC™ (Enhanced-Performance Implanted CMOS) 1- μ m Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic Small-Outline Packages and Standard Plastic 300-mil DIPs

DW OR N PACKAGE
(TOP VIEW)



description

This synchronous, presettable 4-bit decade counter features an internal carry look-ahead circuitry for application in high-speed counting designs. Synchronous operation is provided by having all flip-flops clocked simultaneously so that the outputs change coincident with each other when so instructed by the count-enable inputs and internal gating. This mode of operation eliminates the output counting spikes that are normally associated with asynchronous (ripple clock) counters; however, counting spikes may occur on the ripple carry out output (RCO). A buffered clock input triggers the four flip-flops on the rising (positive-going) edge of the clock input waveform.

This counter is fully programmable in that they may be preset to any number between 0 and 9. As presetting is synchronous, setting up a low level at the load input disables the counter and causes the outputs to agree with the setup data after the next clock pulse, regardless of the levels of the enable inputs. The clear function for the 74AC11160 is synchronous and a low level at the clear input sets all four of the flip-flops outputs low, regardless of the levels of the clock, load, or enable inputs.

If one of these decade counters is preset to a number between 10 and 15 or assumes such an invalid state when power is applied, it will progress to the normal sequence within two counts as shown in the state diagram.

The carry look-ahead circuitry provides for cascading counters for n-bit synchronous applications without additional gating. Instrumental in accomplishing this function are two count-enable inputs and a ripple carry output. Both count-enable inputs (ENP and ENT) must be high to count, and ENT is fed forward to enable the ripple carry output (RCO). RCO thus enabled will produce a high-level pulse while the count is 9 (HLLH). This high-level overflow ripple carry pulse can be used to enable successive cascaded stages. Transitions at the ENP or ENT are allowed regardless of the level of the clock input.

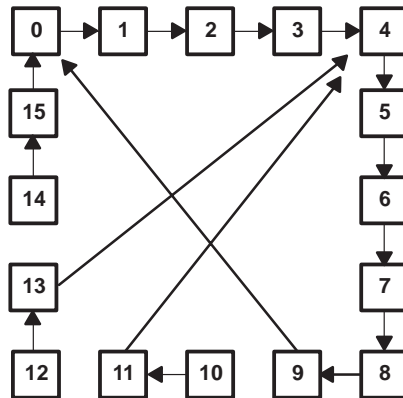
This counter features a fully independent clock circuit. Changes at control inputs (ENP, ENT, or LOAD) that will modify the operating mode have no effect on the contents of the counter until clocking occurs. The function of the counter (whether enabled, disabled, loading, or counting) will be dictated solely by the conditions meeting the setup and hold times.

The 74AC11160 is characterized for operation from –40°C to 85°C.

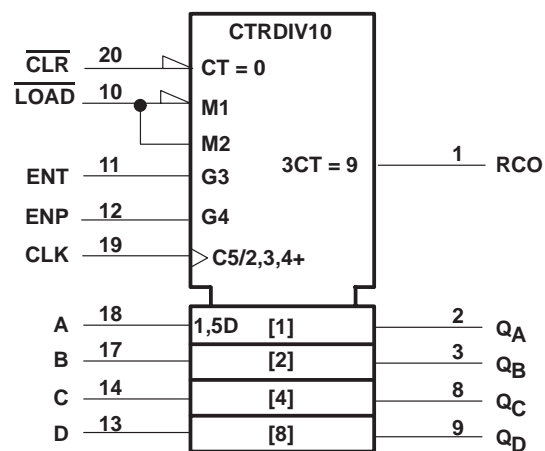
74AC11160 SYNCHRONOUS 4-BIT DECADE COUNTER

SCAS380 –D3199, AUGUST 1988 – REVISED APRIL 1993

state diagram



logic symbol†

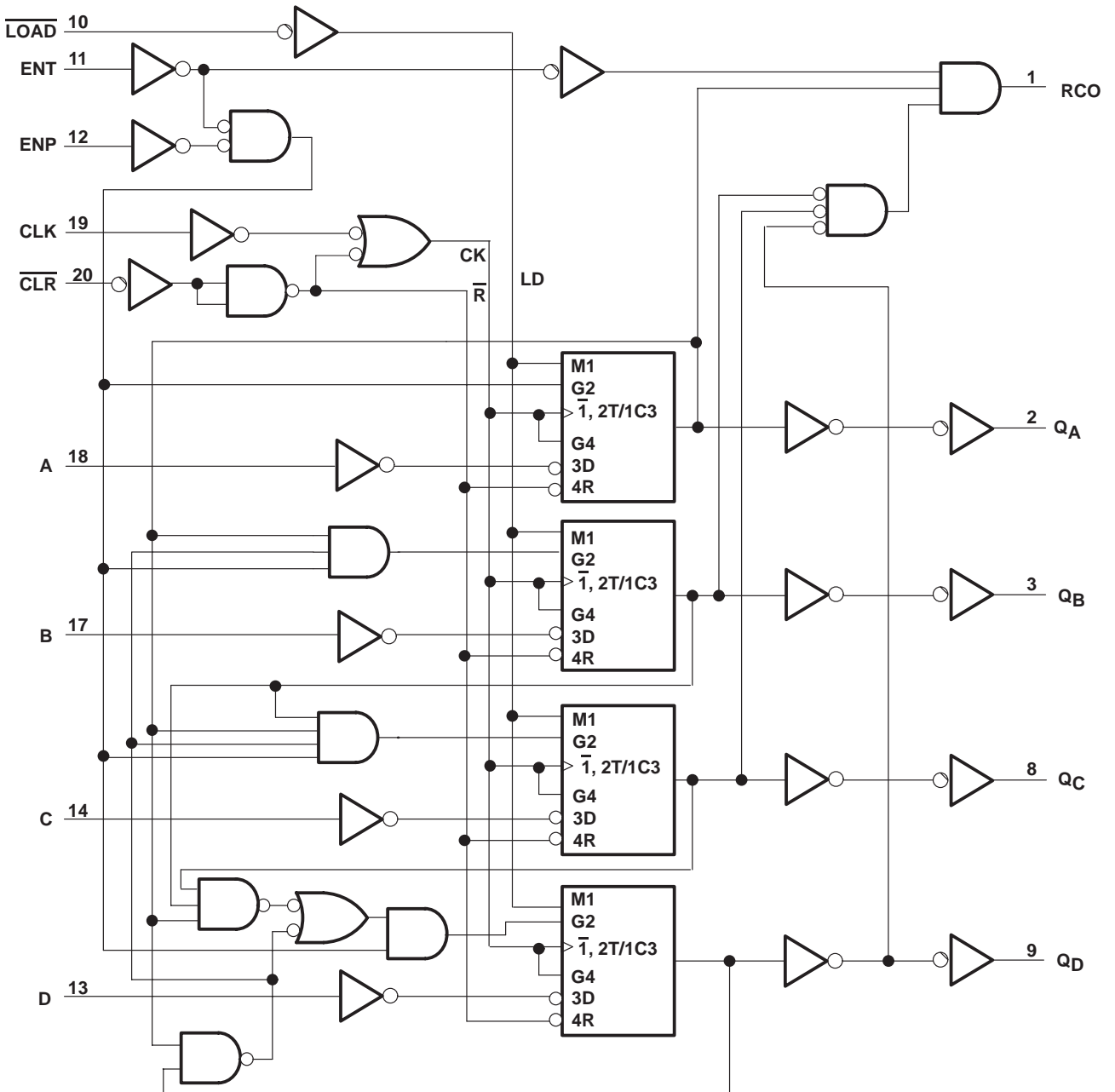


† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

74AC1160 SYNCHRONOUS 4-BIT DECADE COUNTER

SCAS380 – D3199, AUGUST 1988 – REVISED APRIL 1993

logic diagram (positive logic)[†]



74AC11160

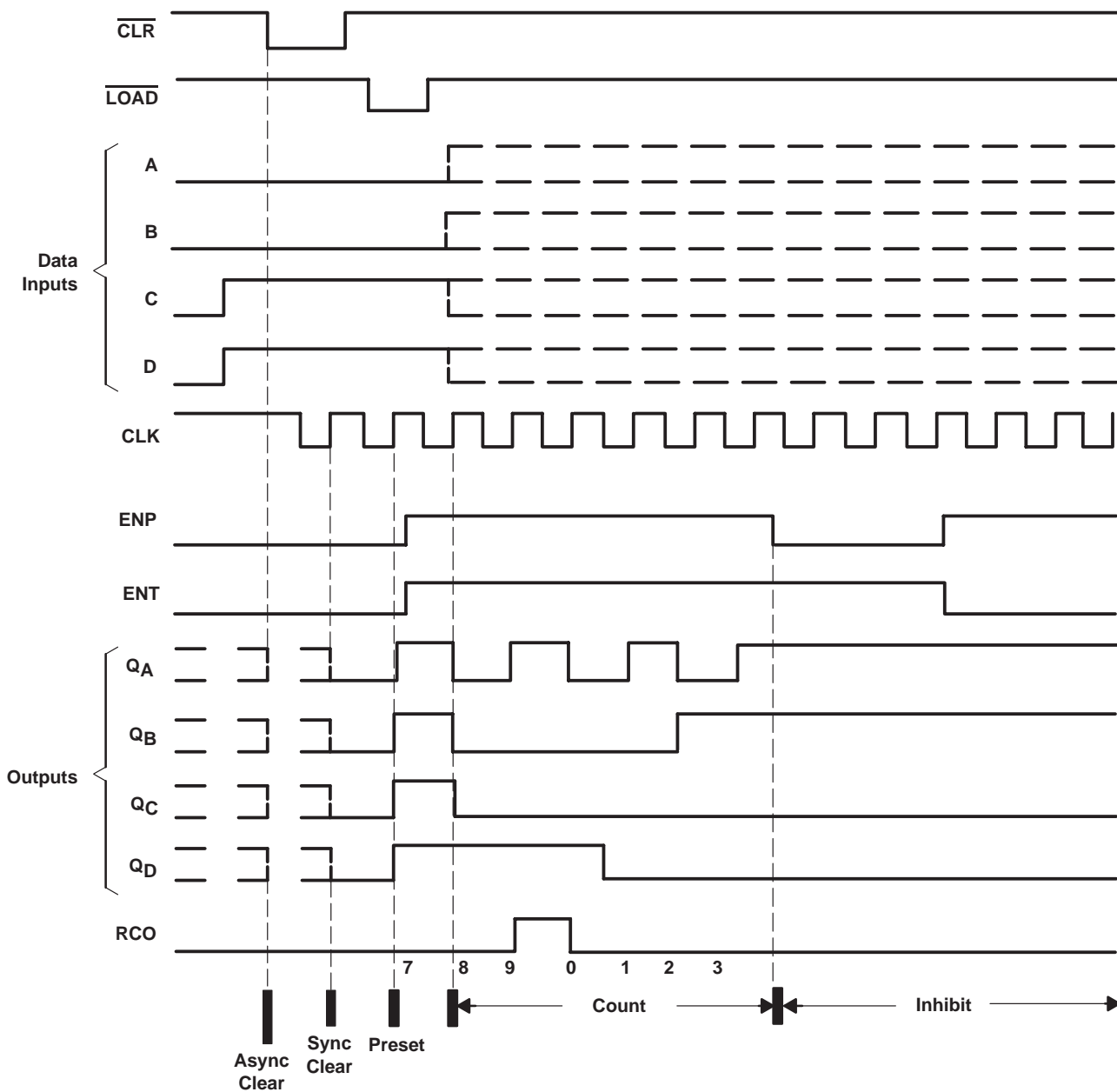
SYNCHRONOUS 4-BIT DECADE COUNTER

SCAS380 –D3199, AUGUST 1988 – REVISED APRIL 1993

output sequence

Illustrated below is the following sequence:

1. Clear outputs to zero (54AC11160 and 74AC11160 are synchronous)
2. Preset to BCD seven
3. Count to eight, nine, zero, one, two, and three
4. Inhibit.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V_{CC}	–0.5 V to 7 V
Input voltage range, V_I (see Note 1)	–0.5 V to $V_{CC} + 0.5$ V
Output voltage range, V_O (see Note 1)	–0.5 V to $V_{CC} + 0.5$ V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±50 mA
Continuous current through V_{CC} or GND pins	±125 mA
Storage temperature range	–65°C to 150°C

[†] Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

recommended operating conditions (see Note 2)

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	3	5	5.5	V
V_{IH}	High-level input voltage	$V_{CC} = 3$ V	2.1		V
		$V_{CC} = 4.5$ V	3.15		
		$V_{CC} = 5.5$ V	3.85		
V_{IL}	Low-level input voltage	$V_{CC} = 3$ V		0.9	V
		$V_{CC} = 4.5$ V		1.35	
		$V_{CC} = 5.5$ V		1.65	
V_I	Input voltage	0		V_{CC}	V
V_O	Output voltage	0		V_{CC}	V
I_{OH}	High-level output current	$V_{CC} = 3$ V		–4	mA
		$V_{CC} = 4.5$ V		–24	
		$V_{CC} = 5.5$ V		–24	
I_{OL}	Low-level output current	$V_{CC} = 3$ V		12	mA
		$V_{CC} = 4.5$ V		24	
		$V_{CC} = 5.5$ V		24	
$\Delta t/\Delta v$	Input transition rise or fall rate	0		10	ns/V
T_A	Operating free-air temperature	–40		85	°C

NOTE 2: Unused or floating inputs must be held high or low.

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SYNCHRONOUS 4-BIT DECADE COUNTER

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	T _A = 25°C			MIN	MAX	UNIT
			MIN	TYP	MAX			
V _{OH}	I _{OH} = – 50 µA	3 V	2.9			2.9		V
		4.5 V	4.4			4.4		
		5.5 V	5.4			5.4		
	I _{OH} = – 4 mA	3 V	2.58			2.48		
		4.5 V	3.94			3.8		
		5.5 V	4.94			4.8		
	I _{OH} = – 75 mA†	5.5 V				3.85		
V _{OL}	I _{OL} = 50 µA	3 V			0.1		0.1	V
		4.5 V			0.1		0.1	
		5.5 V			0.1		0.1	
	I _{OL} = 12 mA	3 V			0.36		0.44	
		4.5 V			0.36		0.44	
		5.5 V			0.36		0.44	
	I _{OL} = 75 mA†	5.5 V					1.65	
I _I	V _I = V _{CC} or GND	5.5 V			±0.1		±1	µA
I _{CC}	V _I = V _{CC} or GND, I _O = 0	5.5 V			8		80	µA
C _i	V _I = V _{CC} or GND	5 V		3.5				pF

† Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

timing requirements, V_{CC} = 3.3 V ± 0.3 V (see Figure 1)

			T _A = 25°C		MIN	MAX	UNIT
			MIN	MAX			
f _{clock}	Clock frequency		0	66	0	66	MHz
t _w	Pulse duration	CLK low or high	7.5		7.5		ns
		CLR low	6		6		
t _{su}	Setup time before CLK↑	A, B, C, D	6.5		6.5		ns
		LOAD	6.5		6.5		
		ENT, ENP	6		6		
		CLR inactive	6		6		
t _h	Hold time after CLK↑		1		1		ns

timing requirements, V_{CC} = 5 V ± 0.5 V (see Figure 1)

			T _A = 25°C		MIN	MAX	UNIT
			MIN	MAX			
f _{clock}	Clock frequency		0	110	0	110	MHz
t _w	Pulse duration	CLK low or high	4.5		4.5		ns
		CLR low	4.5		4.5		
t _{su}	Setup time before CLK↑	A, B, C, D	3.5		3.5		ns
		LOAD	6.5		6.5		
		ENT, ENP	4.5		4.5		
		CLR inactive	6		6		
t _h	Hold time after CLK↑		1		1		ns

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switching characteristics over recommended operating free-air temperature range,
 $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$T_A = 25^\circ\text{C}$			MIN	MAX	UNIT
			MIN	TYP	MAX			
f_{max}			66			66		MHz
t_{PLH}	CLK	RCO	1.5	11.2	13.6	1.5	15.2	ns
t_{PHL}			1.5	12.2	15.1	1.5	17.2	
t_{PLH}	CLK ($\overline{\text{LOAD}}$ high)	Any Q	1.5	9	11.2	1.5	12.5	ns
t_{PHL}			1.5	10.6	13.4	1.5	15.1	
t_{PLH}	CLK ($\overline{\text{LOAD}}$ low)	Any Q	1.5	8.6	10.8	1.5	12.1	ns
t_{PHL}			1.5	10.1	12.8	1.5	14.4	
t_{PLH}	ENT	RCO	1.5	6	7.6	1.5	8.3	ns
t_{PHL}			1.5	6.8	8.9	1.5	9.9	
t_{PLH}	$\overline{\text{CLR}}$	Any Q	1.5	12	15.2	1.5	17.3	ns
t_{PHL}		RCO	1.5	14.1	17.3	1.5	19.7	

switching characteristics over recommended operating free-air temperature range,
 $V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$T_A = 25^\circ\text{C}$			MIN	MAX	UNIT
			MIN	TYP	MAX			
f_{max}			110			110		MHz
t_{PLH}	CLK	RCO	1.5	7.8	9.5	1.5	10.7	ns
t_{PHL}			1.5	8.5	10.6	1.5	12.1	
t_{PLH}	CLK ($\overline{\text{LOAD}}$ high)	Any Q	1.5	6.3	8	1.5	8.9	ns
t_{PHL}			1.5	7.4	9.8	1.5	11.2	
t_{PLH}	CLK ($\overline{\text{LOAD}}$ low)	Any Q	1.5	6	7.5	1.5	8.4	ns
t_{PHL}			1.5	7.1	9.4	1.5	10.7	
t_{PLH}	ENT	RCO	1.5	4.2	5.5	1.5	6	ns
t_{PHL}			1.5	5	6.7	1.5	7.5	
t_{PLH}	$\overline{\text{CLR}}$	Any Q	1.5	8.2	10.7	1.5	12.1	ns
t_{PHL}		RCO	1.5	9.9	12.2	1.5	13.8	

operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$

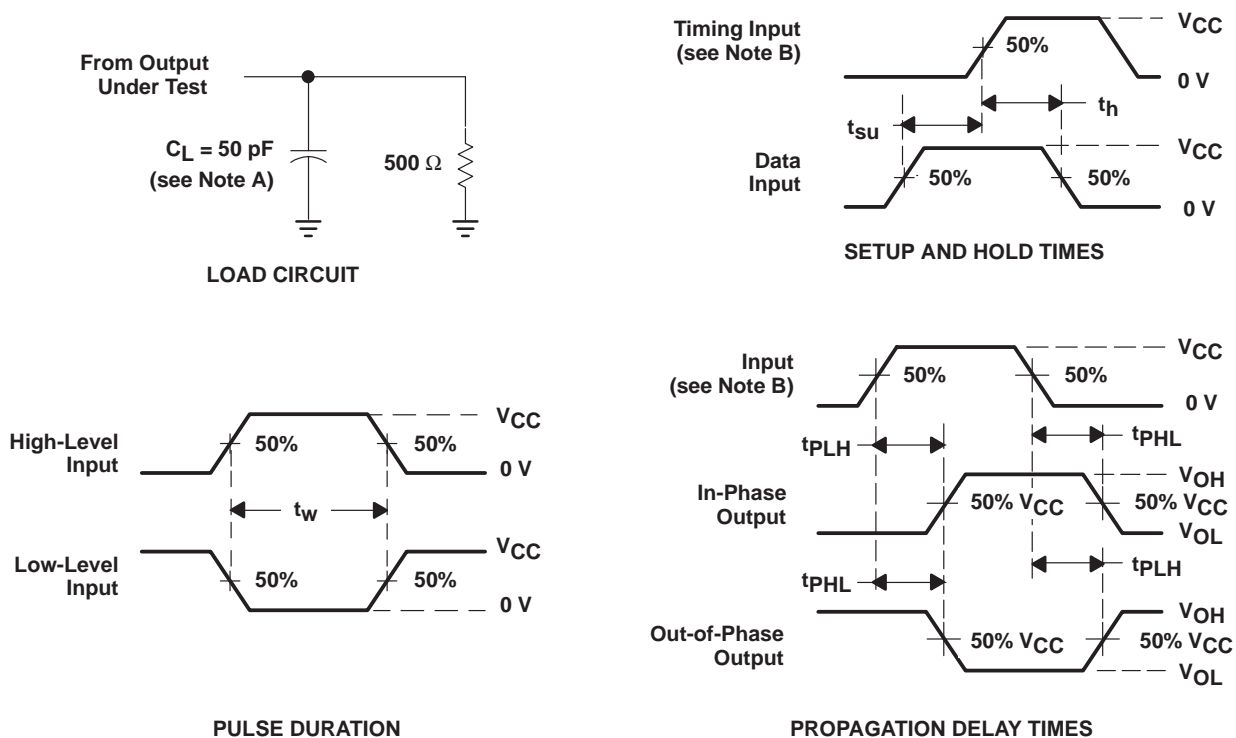
PARAMETER		TEST CONDITIONS	TYP	UNIT
C_{pd}	Power dissipation capacitance	$C_L = 50 \text{ pF}$, $f = 1 \text{ MHz}$	48	pF

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PARAMETER MEASUREMENT INFORMATION



- NOTES: A. C_L includes probe and jig capacitance.
- B. Input pulses are supplied by generators having the following characteristics: $PRR \leq 10 \text{ MHz}$, $Z_O = 50 \Omega$, $t_r = 3 \text{ ns}$, $t_f = 3 \text{ ns}$. For testing f_{max} and pulse duration: $t_r = 1 \text{ to } 3 \text{ ns}$, $t_f = 1 \text{ to } 3 \text{ ns}$.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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